



YOUSHANG SEMICONDUCTOR

设计研发新型功率器件

各类小信号开关

中低压及高压大电流等场效应管

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Product Summary

$V_{(BR)DSS}$	$R_{DS(on) \max}$	I_D $T_A = +25^\circ\text{C}$
-30V	80m Ω @ $V_{GS} = -10\text{V}$	-4.0A
	140m Ω @ $V_{GS} = -4.5\text{V}$	—

Description

This new generation Trench MOSFET is designed to minimize the on-state resistance ($R_{DS(ON)}$) and yet maintain superior switching performance.

Applications

- Power management functions
- Portable Equipment
- Battery Charging

Features and Benefits

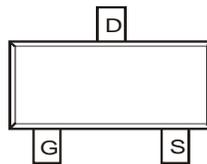
- Low On-Resistance
- Fast Switching Speed
- 4.5V Gate Drive Capability
- Thermally Enhanced SOT23 package

Mechanical Data

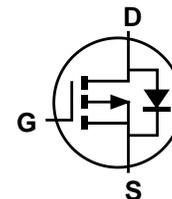
- Package: SOT23
- Package Material: Molded Plastic, "Green" Molding Compound
UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish — Matte Tin annealed over Copper Leadframe
Solderable per MIL-STD-202, Method 208 e3
- Terminal Connections: See Diagram
- Weight: 0.008 grams (approximate)



Top View



Pin Configuration



Equivalent Circuit

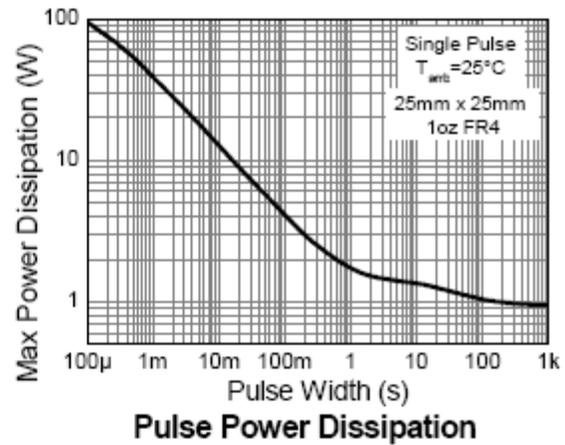
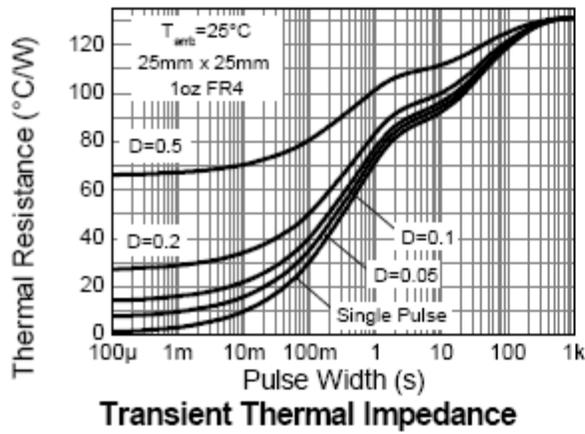
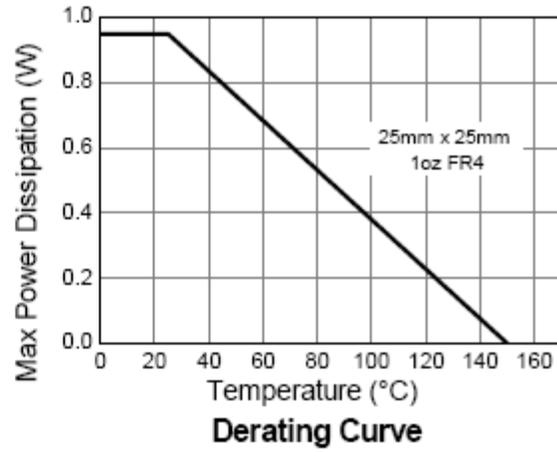
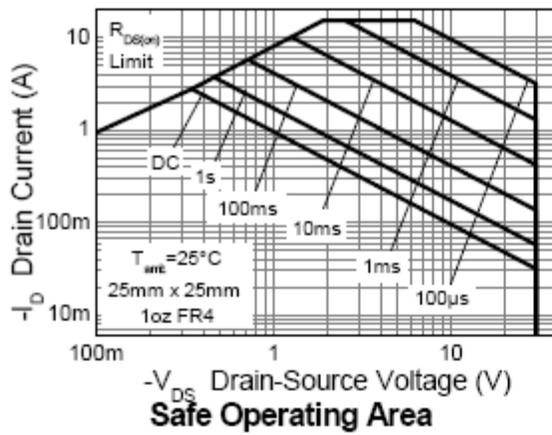
Maximum Ratings (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Drain-Source Voltage		V_{DSS}	-30	V
Gate-Source Voltage		V_{GSS}	± 20	V
Drain Current, $V_{GS} = -10\text{V}$	$T_A = +25^\circ\text{C}$ (Note 6)	I_D	-3.4	A
	$T_A = +70^\circ\text{C}$ (Note 6)		-2.7	
	$T_A = +25^\circ\text{C}$ (Note 5)		-2.8	
	$T_L = +25^\circ\text{C}$ (Note 8)		-4.0	
Pulsed Drain Current (Note 7)		I_{DM}	-15.3	A
Continuous Source Current (Body Diode) (Note 6)		I_S	-2	A
Pulsed Source Current (Body Diode) (Note 7)		I_{SM}	-15.3	A

Thermal Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 5) Linear Derating Factor	$T_A = +25^\circ\text{C}$ (Note 5)	P_D	0.95	W
			7.6	mW/ $^\circ\text{C}$
	$T_A = +25^\circ\text{C}$ (Note 6)		1.4	W
			11.2	mW/ $^\circ\text{C}$
	$T_L = +25^\circ\text{C}$ (Note 8)		1.96	W
Thermal Resistance, Junction to Ambient	(Note 5)	$R_{\theta JA}$	131	$^\circ\text{C}/\text{W}$
	(Note 6)		89	
Operating and Storage Temperature Range		T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

- Notes:
5. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.
 6. Mounted on FR4 PCB measured at $t \leq 10$ sec.
 7. Repetitive rating on 25mm x 25mm FR4 PCB, $D=0.02$, pulse width 300 μs – pulse width limited by maximum junction temperature.
 8. Thermal resistance from junction to solder-point (at the end of the drain lead).

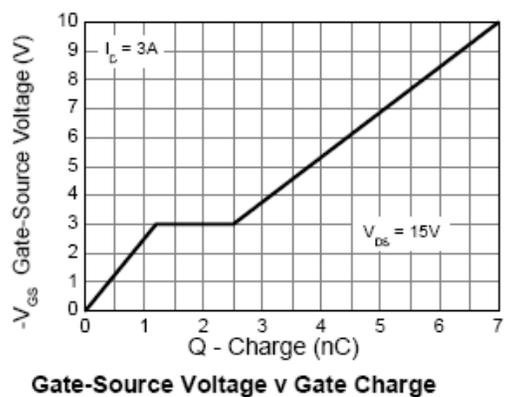
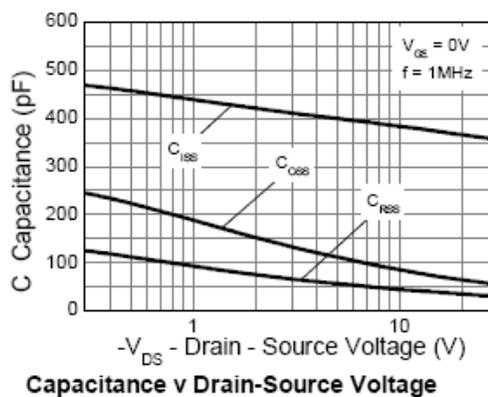
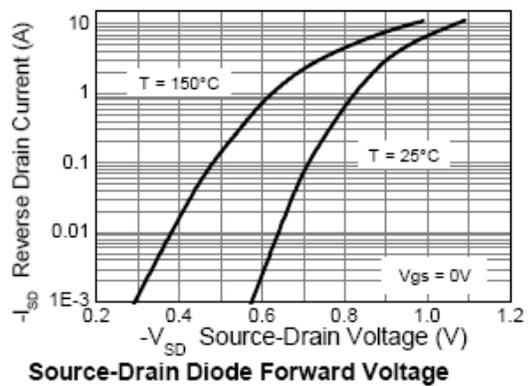
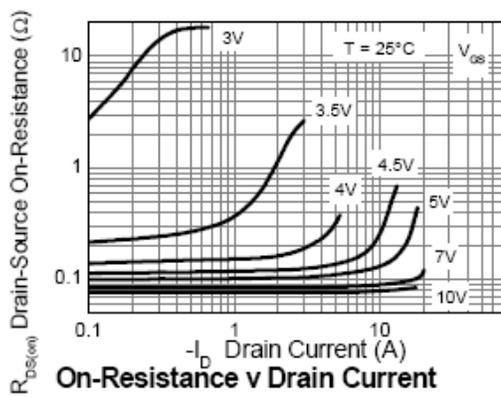
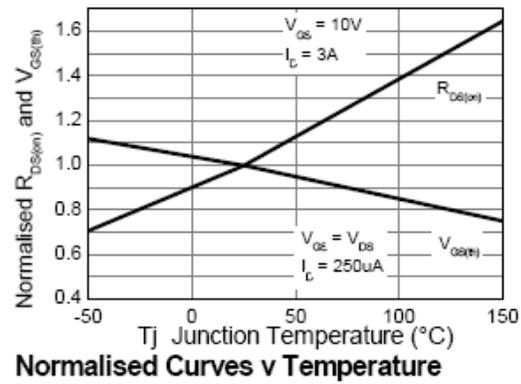
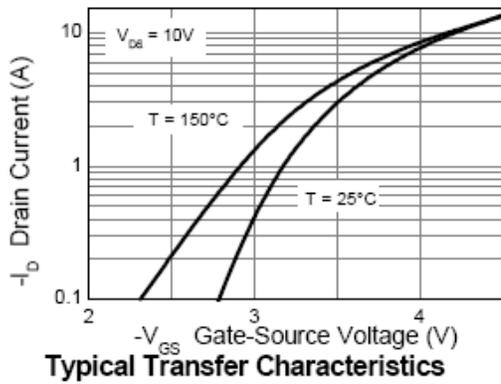
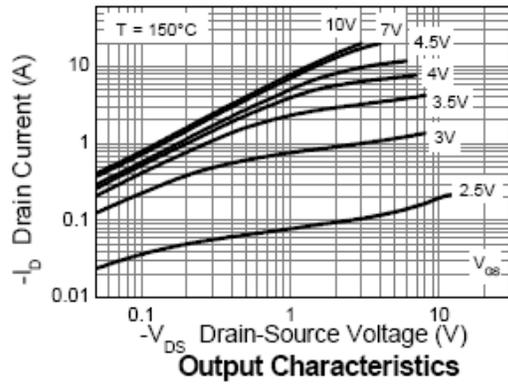
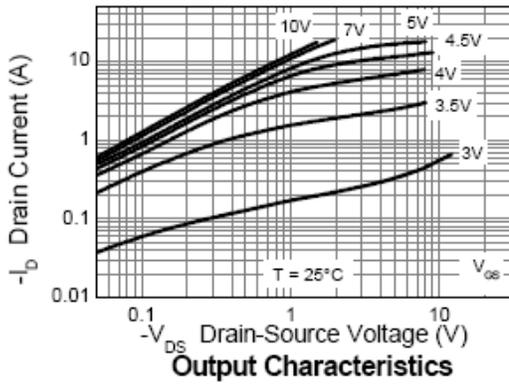


Electrical Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

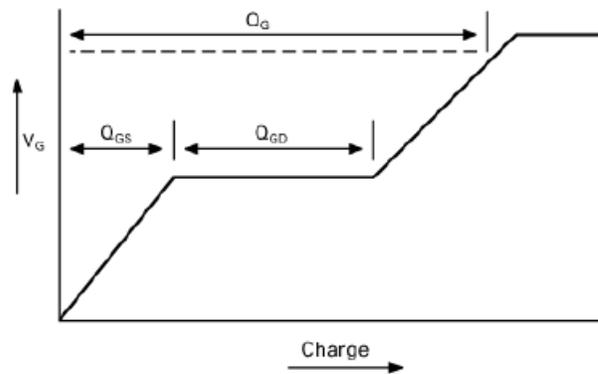
Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	-30	—	—	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current	I_{DSS}	—	—	-1	μA	$V_{DS} = -30V, V_{GS} = 0V$
Gate-Source Leakage	I_{GSS}	—	—	± 100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(th)}$	-1	—	-3	V	$V_{DS} = V_{GS}, I_D = -250\mu A$
Static Drain-Source On-Resistance (Note 9)	$R_{DS(on)}$	—	—	80	m Ω	$V_{GS} = -10V, I_D = -2.5A$
				140		$V_{GS} = -4.5V, I_D = -1.9A$
Forward Transconductance (Note 9 & 10)	g_{fs}	—	5	—	S	$V_{DS} = -15V, I_D = -3A$
Diode Forward Voltage (Note 9)	V_{SD}	—	-0.8	-1.2	V	$V_{GS} = 0V, I_S = -1.7A$
DYNAMIC CHARACTERISTICS (Note 10)						
Input Capacitance	C_{iss}	—	370	—	pF	$V_{DS} = -15V, V_{GS} = 0V,$ $f = 1.0MHz$
Output Capacitance	C_{oss}	—	72	—	pF	
Reverse Transfer Capacitance	C_{rss}	—	38	—	pF	
GATE CHARACTERISTICS						
Total Gate Charge	Q_g	—	7	—	nC	$V_{DS} = -15V, V_{GS} = -10V,$ $I_D = -3A$
Gate-Source Charge	Q_{gs}	—	1.2	—		
Gate-Drain Charge	Q_{gd}	—	1.3	—		
SWITCHING CHARACTERISTICS (Note 10 & 11)						
Turn-On Delay Time	$t_{d(on)}$	—	1.3	—	ns	$V_{DS} = -15V, V_{GS} = -10V,$ $I_D = -1A, R_G = 6.0\Omega$
Rise Time	t_r	—	2.6	—		
Turn-Off Delay Time	$t_{d(off)}$	—	49	—		
Fall Time	t_f	—	22	—		
SOURCE-DRAIN DIODE CHARACTERISTICS (Note 11)						
Reverse Recovery Time	t_{rr}	—	14.6	—	ns	$I_S = -1.5A, di/dt = 100A/\mu s$
Reverse Recovery Charge	Q_{rr}	—	9.5	—	nC	

Notes: 9. Measured under pulsed conditions. Pulse width $\leq 300\mu s$; duty cycle $\leq 2\%$.
 10. Switching characteristics are independent of operating junction temperature.
 11. For design aid only, not subject to production testing.

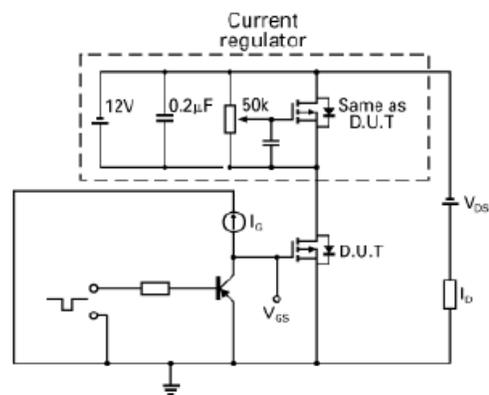
Typical Characteristics



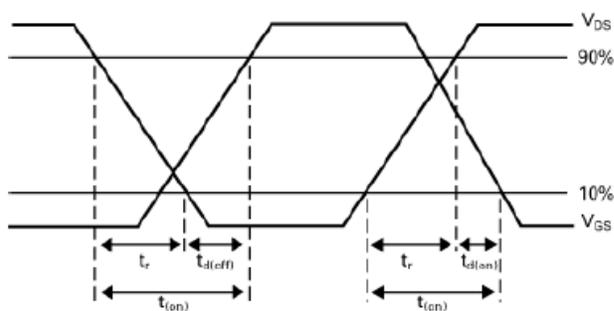
Test Circuits



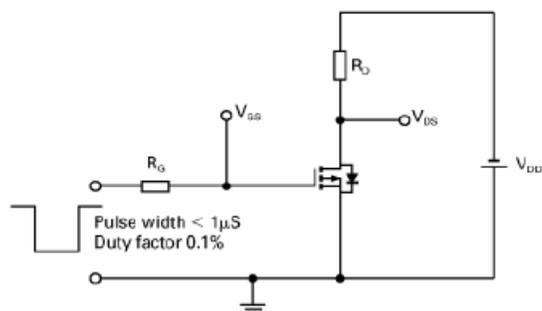
Basic gate charge waveform



Gate charge test circuit

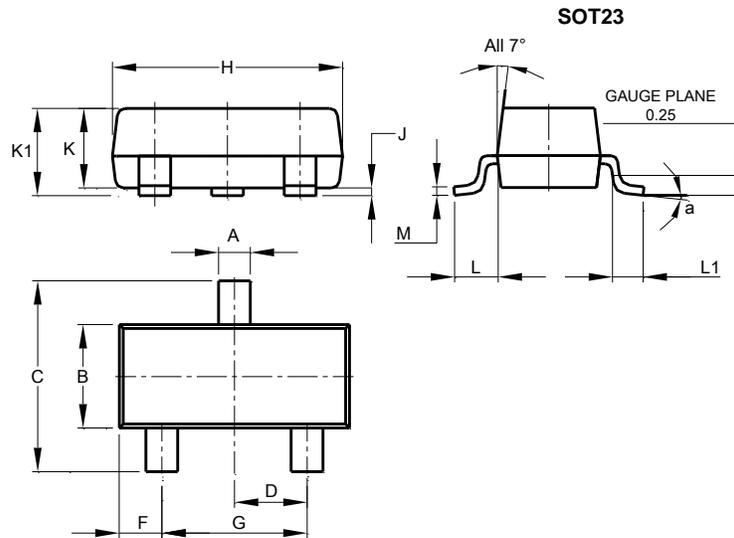


Switching time waveforms



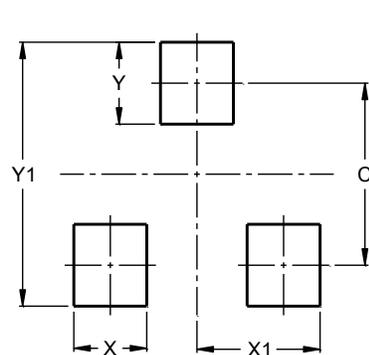
Switching time test circuit

Package Outline Dimensions



SOT23			
Dim	Min	Max	Typ
A	0.37	0.51	0.40
B	1.20	1.40	1.30
C	2.30	2.50	2.40
D	0.89	1.03	0.915
F	0.45	0.60	0.535
G	1.78	2.05	1.83
H	2.80	3.00	2.90
J	0.013	0.10	0.05
K	0.890	1.00	0.975
K1	0.903	1.10	1.025
L	0.45	0.61	0.55
L1	0.25	0.55	0.40
M	0.085	0.150	0.110
a	0°	8°	--
All Dimensions in mm			

Suggested Pad Layout



Dimensions	Value (in mm)
C	2.0
X	0.8
X1	1.35
Y	0.9
Y1	2.9